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April 2015

NDT2955

P-Channel Enhancement Mode Field Effect Transistor

General Description

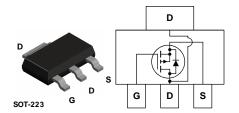
This 60V P-Channel MOSFET is produced using Fairchild Semiconductor's high voltage Trench process. It has been optimized for power management plications.

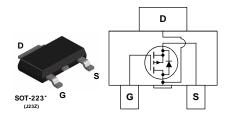
Applications

- DC/DC converter
- Power management

Features

- -2.5 A, -60 V. $R_{DS(ON)}=300m\Omega$ @ $V_{GS}=-10$ V $R_{DS(ON)}=500m\Omega$ @ $V_{GS}=-4.5$ V
- High density cell design for extremely low R_{DS(ON)}
- High power and current handling capability in a widely used surface mount package.





Absolute Maximum Ratings T_A=25°C unless otherwise noted

9 "				
Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-60	V
V _{GSS}	Gate-Source Voltage		±20	V
I _D	Drain Current - Continuous	(Note 1a)	-2.5	Α
	– Pulsed		–15	
P _D	Maximum Power Dissipation	(Note 1a)	3.0	W
		(Note 1b)	1.3	
		(Note 1c)	1.1	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	42	°C/W
R _{eJC}	Thermal Resistance, Junction-to-Case	(Note 1)	12	

Package Marking and Ordering Information

		,		
Device Marking	Device	Reel Size	Tape width	Quantity
2955	NDT2955	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Avalanc	he Ratings	1		ı		
W _{DSS}	Drain-Source Avalanche Energy	Single Pulse, $V_{DD} = 30 \text{ V}$, $I_D = 2.5 \text{ A}$			174	mJ
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = -250 \mu\text{A}$	-60			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		-60		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -60 \text{ V}, V_{GS} = 0 \text{ V}$			-10	μΑ
GSSF	Gate-Body Leakage, Forward	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I_{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$	-2	-2.6	-4	V
$\Delta V_{GS(th)} \ \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		5.7		mV/°C
R _{DS(on)}	Static Drain-Source	$V_{GS} = -10 \text{ V}, I_{D} = -2.5 \text{ A}$		95	300	$m\Omega$
	On–Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -2 \text{ A}$		163 153	500 513	
I _{D(on)}	On–State Drain Current	V_{GS} =-10 V, I_D =-2.5 A, T_J =125°C V_{GS} = -10 V, V_{DS} = -5 V	-12	133	313	Α
9FS	Forward Transconductance	$V_{DS} = -10 \text{ V}, I_{D} = -2.5 \text{ A}$	12	5.5		S
	Characteristics	155 10 1, 15 110 11			l	
C _{iss}	Input Capacitance	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V},$		601		pF
Coss	Output Capacitance	f = 1.0 MHz		85		pF
C _{rss}	Reverse Transfer Capacitance	7		35		pF
Switchin	ng Characteristics (Note 2)	1	1	ı	ı	
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -30 \text{ V}, I_{D} = -1 \text{ A},$		12	21	ns
t _r	Turn-On Rise Time	$V_{GS} = -10 \text{ V}, R_{GEN} = 6 \Omega$		10	20	ns
t _{d(off)}	Turn-Off Delay Time			19	34	ns
t _f	Turn-Off Fall Time			6	12	ns
Q_g	Total Gate Charge	$V_{DS} = -30 \text{ V}, I_{D} = -2.5 \text{ A},$		11	15	nC
Q_{gs}	Gate-Source Charge	V _{GS} = -10 V		2.4		nC
Q_{gd}	Gate-Drain Charge			2.7		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
I _S	Maximum Continuous Drain-Source				-2.5	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -2.5 \text{ A} \text{(Note 2)}$		-0.8	-1.2	V
t _{rr}	Diode Reverse Recovery Time	$I_F = -2.5 \text{ A},$		25		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$		40		nC

Notes

1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 42°C/W when mounted on a 1in² pad of 2 oz copper



b) 95°C/W when mounted on a .0066 in² pad of 2 oz



c) 110°C/W when mounted on a minimum pad.

^{2.} Pulse Test: Pulse Width < 300μ s, Duty Cycle < 2.0%

Typical Characteristics

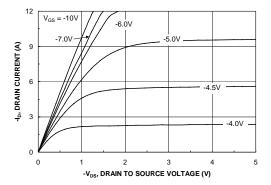


Figure 1. On-Region Characteristics.

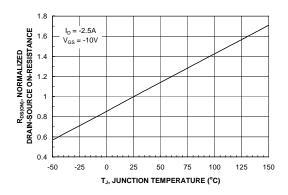


Figure 3. On-Resistance Variation withTemperature.

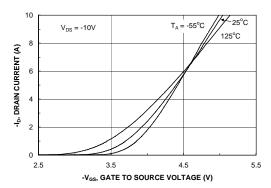


Figure 5. Transfer Characteristics.

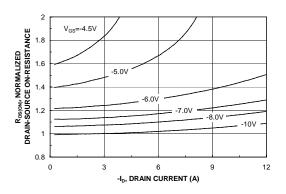


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

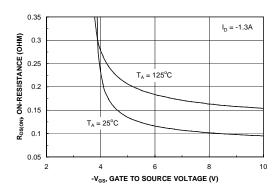


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

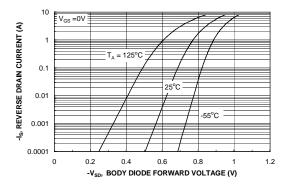
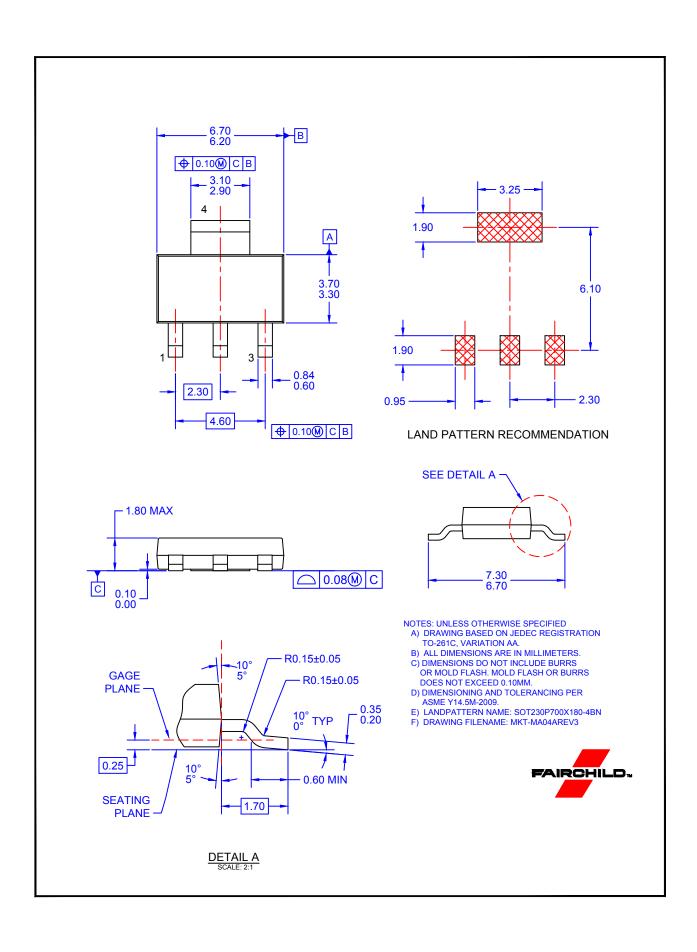


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.



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